

**Search Notes**

Application/Control No.

10/506,568

Examiner

KEVIN L. LEE

Applicant(s)/Patent under  
Reexamination

WEH ET AL.

Art Unit

3753

**SEARCHED**

Class	Subclass	Date	Examiner
137	614.11	5/28/2007	KL
UPDATED	SEARCH	5/28/2007	KL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
EAST	US- PGPUB	5/28/2007	KL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Interference search (US-PGPUB)	5/28/2007	KL